

TOSHIBA Power Transistor Module  
Silicon NPN&PNP Epitaxial Type (Darlington power transistor 4 in 1)

# MP4005

## High Power Switching Applications.

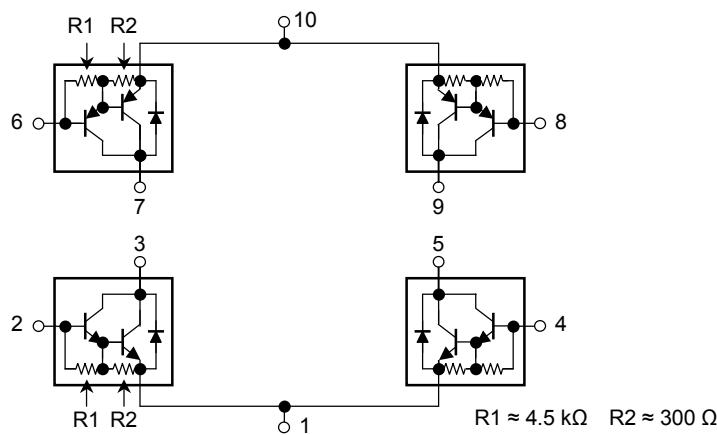
Hammer Drive, Pulse Motor Drive and Inductive Load Switching.

- Small package by full molding (SIP 10 pin)
- High collector power dissipation (4 devices operation)  
:  $P_T = 4 \text{ W}$  ( $T_a = 25^\circ\text{C}$ )
- High collector current:  $I_C (\text{DC}) = \pm 4 \text{ A}$  (max)
- High DC current gain:  $hFE = 2000$  (min) ( $V_{CE} = \pm 2 \text{ V}$ ,  $I_C = \pm 1 \text{ A}$ )

## Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

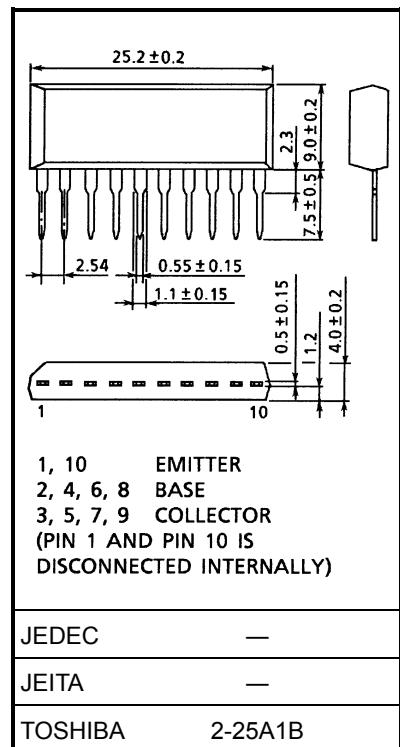
Characteristics	Symbol	Rating		Unit
		NPN	PNP	
Collector-base voltage	$V_{CBO}$	100	-100	V
Collector-emitter voltage	$V_{CEO}$	80	-80	V
Emitter-base voltage	$V_{EBO}$	5	-5	V
Collector current	DC	$I_C$	4	A
	Pulse	$I_{CP}$	6	
Continuous base current	$I_B$	0.4	-0.4	A
Collector power dissipation (1 device operation)	$P_C$	2.0		W
Collector power dissipation (4 devices operation)	$P_T$	4.0		W
Junction temperature	$T_j$	150		°C
Storage temperature range	$T_{stg}$	-55 to 150		°C

## Array Configuration



## Industrial Applications

Unit: mm



Weight: 2.1 g (typ.)

(Pin 1 and pin 10 is disconnected internally)

## Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance of junction to ambient (4 devices operation, $T_a = 25^\circ\text{C}$ )	$\Sigma R_{\text{th}} (\text{j-a})$	31.3	$^\circ\text{C/W}$
Maximum lead temperature for soldering purposes (3.2 mm from case for 10 s)	$T_L$	260	$^\circ\text{C}$

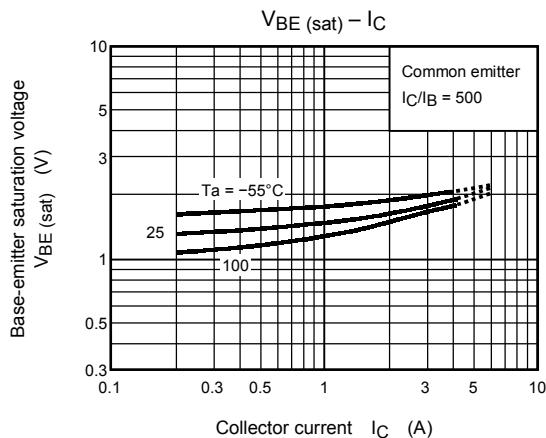
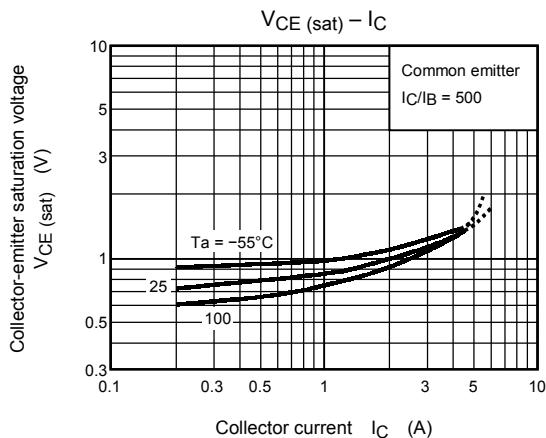
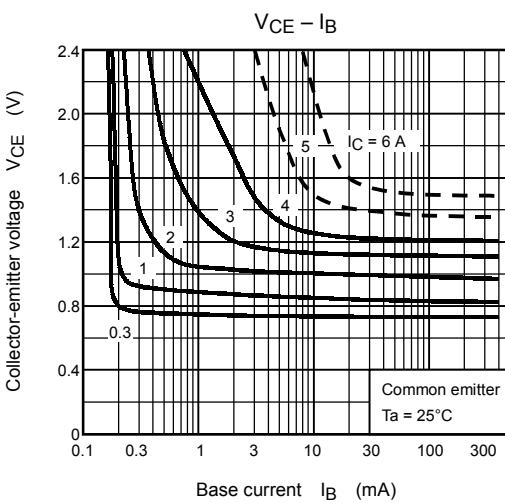
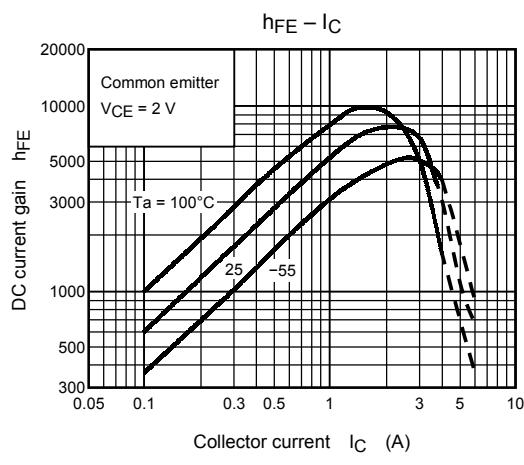
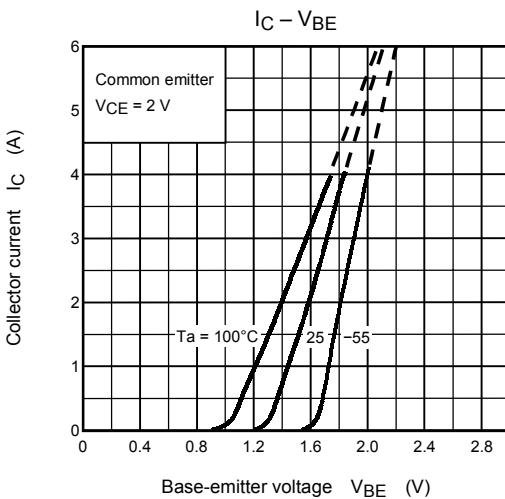
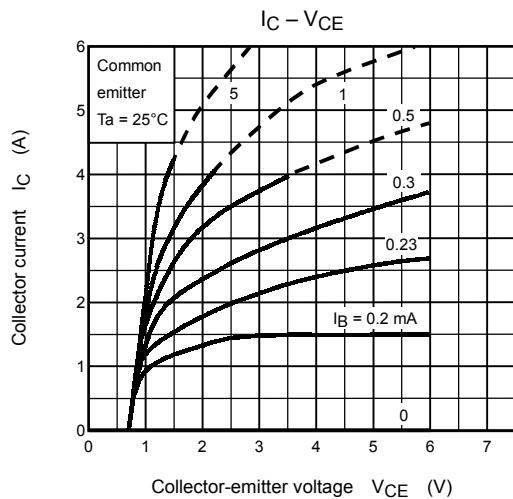
Electrical Characteristics ( $T_a = 25^\circ\text{C}$ ) (NPN transistor)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current	$I_{\text{CBO}}$	$V_{\text{CB}} = 100 \text{ V}, I_E = 0 \text{ A}$	—	—	20	$\mu\text{A}$
Collector cut-off current	$I_{\text{CEO}}$	$V_{\text{CE}} = 80 \text{ V}, I_B = 0 \text{ A}$	—	—	20	$\mu\text{A}$
Emitter cut-off current	$I_{\text{EBO}}$	$V_{\text{EB}} = 5 \text{ V}, I_C = 0 \text{ A}$	0.5	—	2.5	$\text{mA}$
Collector-base breakdown voltage	$V_{(\text{BR})\text{CBO}}$	$I_C = 1 \text{ mA}, I_E = 0 \text{ A}$	100	—	—	$\text{V}$
Collector-emitter breakdown voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = 10 \text{ mA}, I_B = 0 \text{ A}$	80	—	—	$\text{V}$
DC current gain	$h_{\text{FE}} (1)$	$V_{\text{CE}} = 2 \text{ V}, I_C = 1 \text{ A}$	2000	—	—	—
	$h_{\text{FE}} (2)$	$V_{\text{CE}} = 2 \text{ V}, I_C = 3 \text{ A}$	1000	—	—	
Saturation voltage	Collector-emitter	$V_{\text{CE}} (\text{sat})$	$I_C = 3 \text{ A}, I_B = 6 \text{ mA}$	—	—	1.5
	Base-emitter	$V_{\text{BE}} (\text{sat})$	$I_C = 3 \text{ A}, I_B = 6 \text{ mA}$	—	—	2.0
Transition frequency	$f_T$	$V_{\text{CE}} = 2 \text{ V}, I_C = 0.5 \text{ A}$	—	60	—	$\text{MHz}$
Collector output capacitance	$C_{\text{ob}}$	$V_{\text{CB}} = 10 \text{ V}, I_E = 0 \text{ A}, f = 1 \text{ MHz}$	—	30	—	$\text{pF}$
Switching time	Turn-on time	$t_{\text{on}}$		—	0.2	—
	Storage time	$t_{\text{stg}}$		—	1.5	—
	Fall time	$t_f$		—	0.6	—

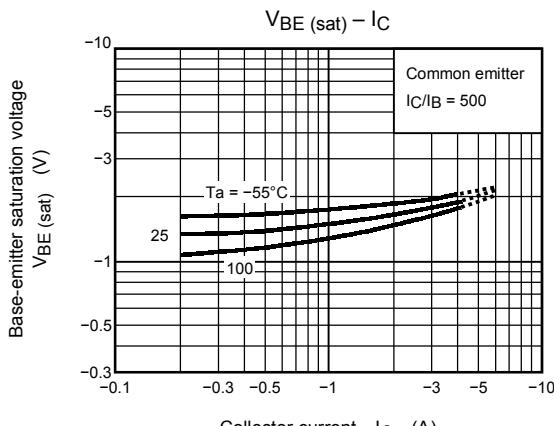
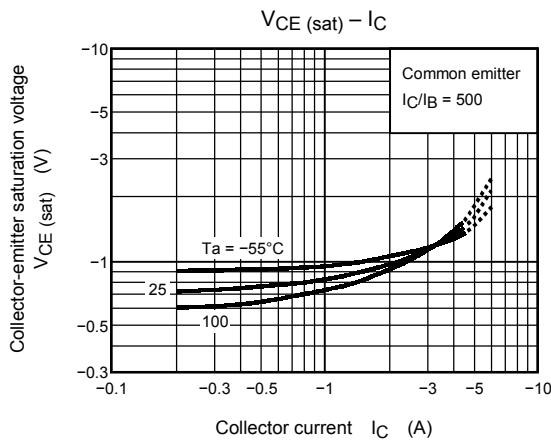
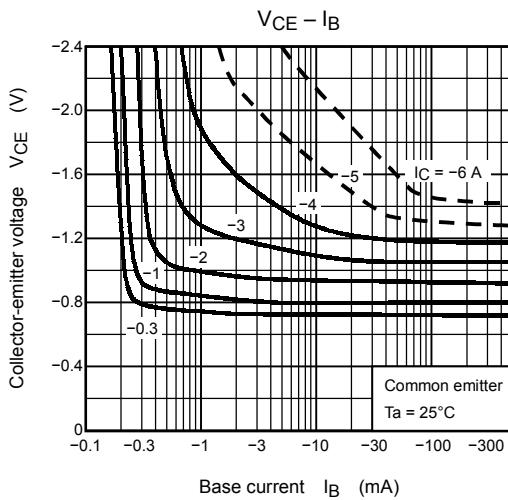
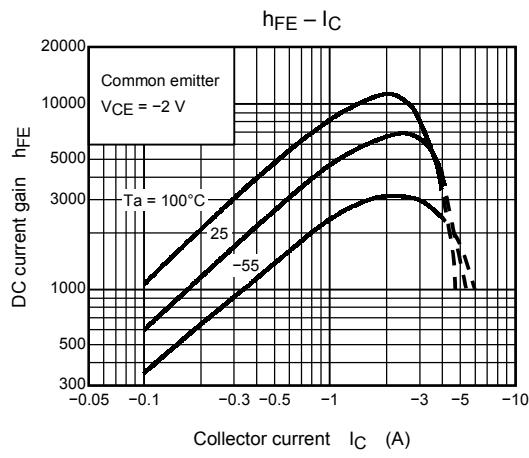
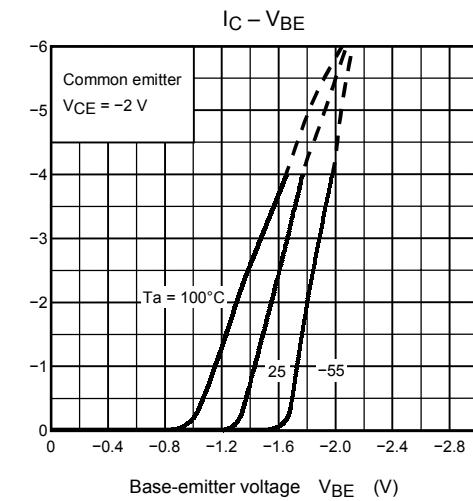
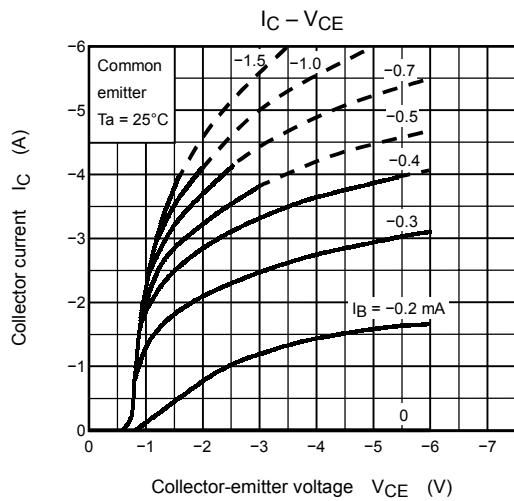
Electrical Characteristics ( $T_a = 25^\circ\text{C}$ ) (PNP transistor)

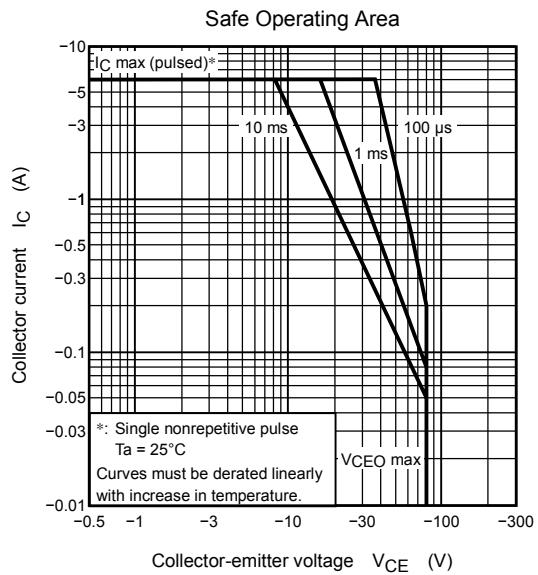
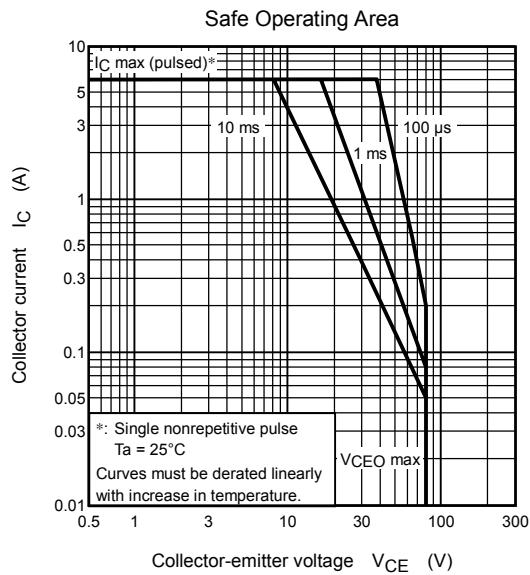
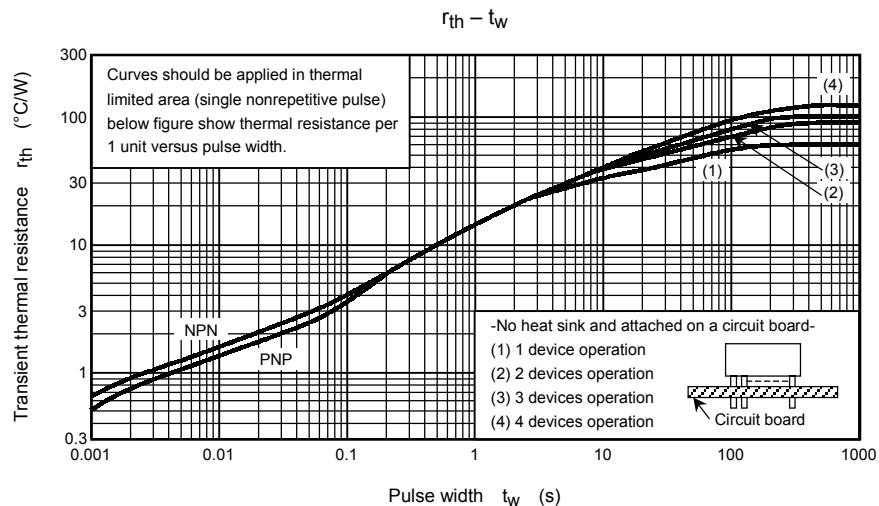
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current	$I_{CBO}$	$V_{CB} = -100 \text{ V}, I_E = 0 \text{ A}$	—	—	-20	$\mu\text{A}$
Collector cut-off current	$I_{CEO}$	$V_{CE} = -80 \text{ V}, I_B = 0 \text{ A}$	—	—	-20	$\mu\text{A}$
Emitter cut-off current	$I_{EBO}$	$V_{EB} = -5 \text{ V}, I_C = 0 \text{ A}$	-0.5	—	-2.5	mA
Collector-base breakdown voltage	$V_{(\text{BR})\text{CBO}}$	$I_C = -1 \text{ mA}, I_E = 0 \text{ A}$	-100	—	—	V
Collector-emitter breakdown voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = -10 \text{ mA}, I_B = 0 \text{ A}$	-80	—	—	V
DC current gain	$h_{FE}$ (1)	$V_{CE} = -2 \text{ V}, I_C = -1 \text{ A}$	2000	—	—	—
	$h_{FE}$ (2)	$V_{CE} = -2 \text{ V}, I_C = -3 \text{ A}$	1000	—	—	
Saturation voltage	Collector-emitter	$V_{CE} (\text{sat})$	$I_C = -3 \text{ A}, I_B = -6 \text{ mA}$	—	—	-1.5
	Base-emitter	$V_{BE} (\text{sat})$	$I_C = -3 \text{ A}, I_B = -6 \text{ mA}$	—	—	-2.0
Transition frequency	$f_T$	$V_{CE} = -2 \text{ V}, I_C = -0.5 \text{ A}$	—	40	—	MHz
Collector output capacitance	$C_{ob}$	$V_{CB} = -10 \text{ V}, I_E = 0 \text{ A}, f = 1 \text{ MHz}$	—	55	—	pF
Switching time	Turn-on time	$t_{on}$	 $-I_{B1} = I_{B2} = 6 \text{ mA}$ , duty cycle $\leq 1\%$			
	Storage time	$t_{stg}$	—	0.15	—	$\mu\text{s}$
	Fall time	$t_f$	—	0.80	—	
			—	0.40	—	

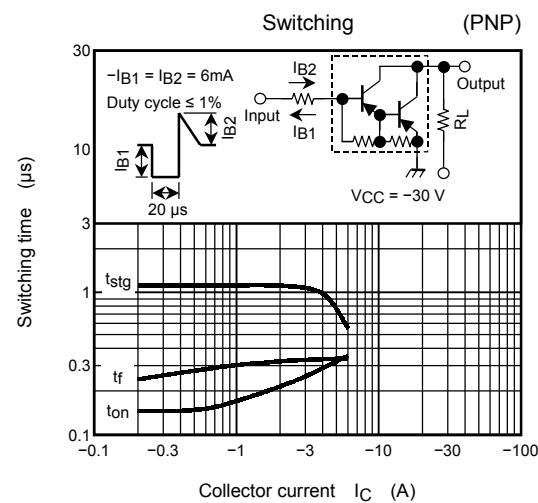
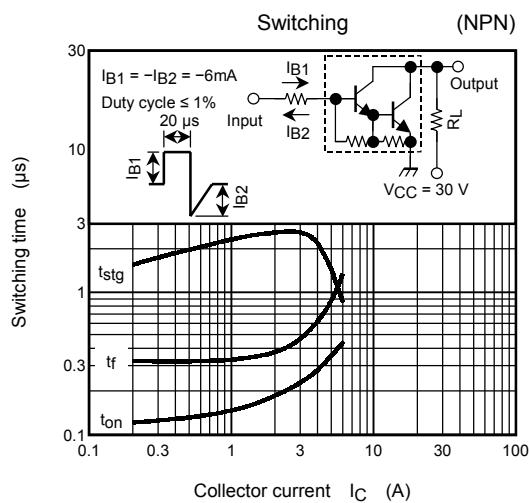
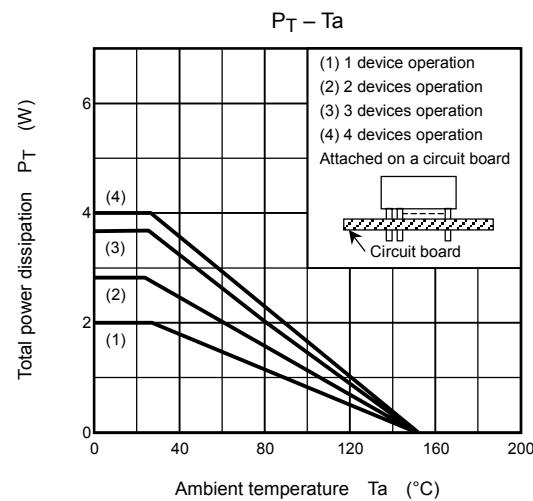
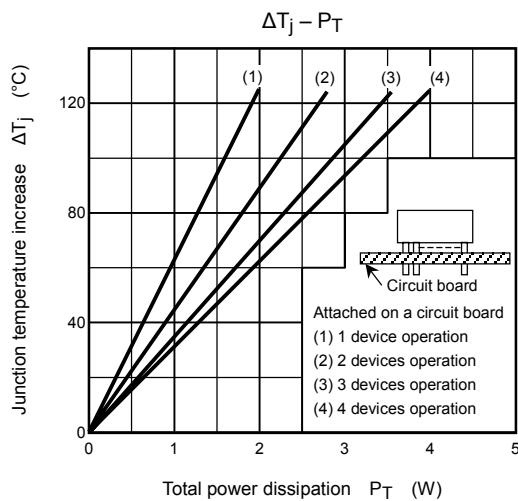
## (NPN transistor)



(PNP transistor)







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